

New Formulations of Design Optimization for Six-sigma, Reliability and Robustness

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Optimal Design Problem Formulation



- Elements of an optimal design problem
 - Objective function (Single or multi-objective)
 - Design variables (Size, shape, topology, concept)
 - Constraints
 - System equations
 - Systems with uncertainty → Robust design, RBDO
- Information on probability distributions of uncertain variables necessary

Issues for RBDO and Kwak's contributions



- How to calculate Reliability
 - Monte Carlo simulation, Reliability index,...
 - Moment with DOE, Expanding Response Surface Moment Method (RSMM)
- How to treat probability constraints --Sub-optimization problem
 - RIA (Reliability index approach)
 - FNA (Fixed norm approach)
- How to solve the RBDO
 - Approximate gradient approach: FDM, Utilize DOE
 - Gradient-based approach: Sensitivity using POD
- DOE based RBDO Procedure
(Moment using 3 pt info) + (Pearson sys) + (Sensitivity with DOE)

Issues for Robust Optimal Design

- How to define Robust Optimal Design?
 - Minimum “sensitivity” to “uncertainties”
 - No universal consensus yet
- How to formulate a robust optimal design?
 - Using RBDO → Too expensive to get solution and probability information
 - Without using probability info → Simple and efficient
 - Using GI
 - Allowable set approach (ALS)
 - Taguchi method

Robust optimal design with Gradient Index

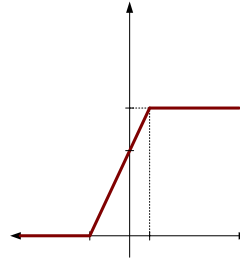
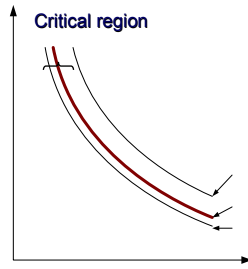
- Conventional optimization formulation

$$\begin{array}{ll} \text{Minimize} & f(\mathbf{x}, \mathbf{z}) \\ \text{subject to} & g_j(\mathbf{x}, \mathbf{z}) \leq 0 \quad j=1,2,\dots,m \\ & \mathbf{x}_L \leq \mathbf{x} \leq \mathbf{x}_U \end{array}$$

- Robust optimization formulation using GI

$$\begin{array}{ll} \text{Minimize} & \text{GI} \\ \text{subject to} & g_j(\mathbf{x}, \mathbf{z}) + \Psi_j(g_j(\mathbf{x}, \mathbf{z})) \leq 0 \quad j=1,2,\dots,m \\ & f(\mathbf{x}, \mathbf{z}) \equiv M \end{array}$$

Feasibility robustness using GI_{gj}

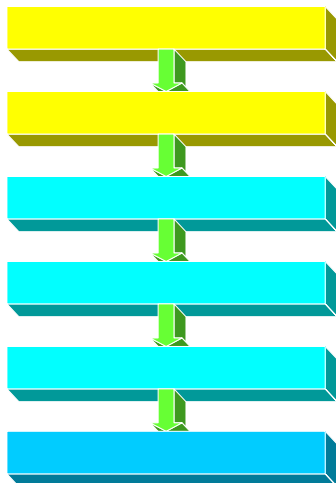


$$\Psi_j(g_j) = \begin{cases} 0 & g_j < CT \\ \frac{\kappa_j GI_{gj}}{CTMIN - CT} (g_j - CT) & CT \leq g_j \leq CTMIN \\ \kappa_j GI_{gj} & g_j > CTMIN \end{cases}$$

CT: small negative value
CTMIN: small positive value
 κ_j : factor for GI_{gj}

$$GI_{gj} = \max_i \left| \frac{dg_j}{du_i} \right| \quad i = 1, 2, \dots, N$$

Robust optimal design procedure for MEMS structures

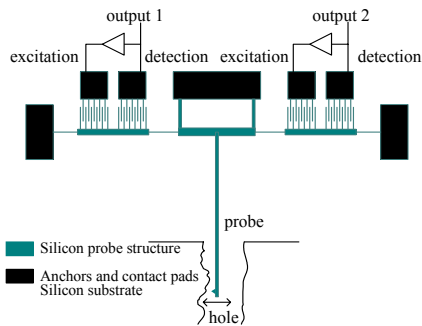


- Identify important characteristics and constraints
- Find out what we can modify or change
- Perform deterministic optimizations to improve the performances
- Select uncertain variables in consideration of fabrication processes and other uncertainties
- SA for objective and constraint functions w.r.t. u_i
- For both initial and deterministic optimal designs
- Select critical u_i and responses for robust design
- Define GI
- Perform robust optimizations using the GI

Ex1: Resonant-type micro probe

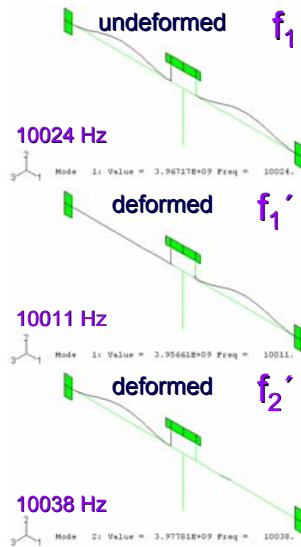
[Lebrasseur, 2000]

Principle of operation



- High aspect ratio micro holes
- Stress-induced frequency shift
- Working mode is the first resonant mode

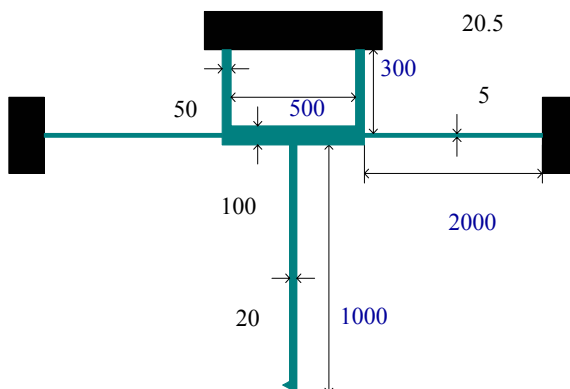
Measurement sensitivity: $\Delta f / f (\%) = (f_2' - f_1') / f_1 \times 100$



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Identification

Design variables



- $1000 \leq x_1 \leq 1500$
- $1000 \leq x_2 \leq 3000$
- $200 \leq x_3 \leq 500$
- $300 \leq x_4 \leq 800$
- $3 \leq x_5 \leq 80$
- $3 \leq x_6 \leq 30$
- $10 \leq x_7 \leq 100$
- $20 \leq x_8 \leq 200$
- $15 \leq x_9 \leq 25$

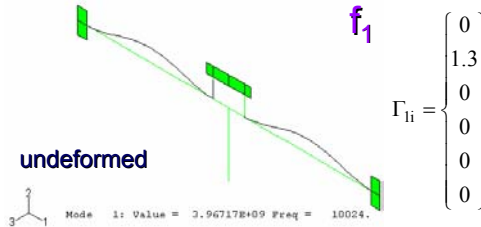
Unit: μm

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Deterministic optimization

Maximize $\Delta f / f$ (%)
 subject to $f_1 \geq 10000 \text{ Hz}$
 $f_3 \geq 20000 \text{ Hz}$
 $\sigma_{\max} \leq \sigma_{\text{yield}}$
 $f_{\Gamma_{li}} - f_1 \leq 0.001$
 $\Delta f / f \equiv M$

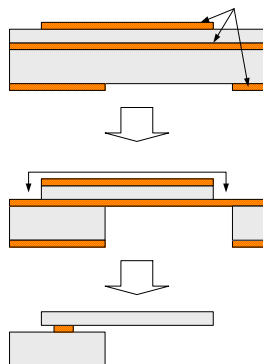
: measurement sensitivity
 : $\text{freq}_1 \geq 10 \text{ kHz}$
 : $\text{freq}_3 \geq 20 \text{ kHz}$
 : $\sigma_{\max(1 \mu\text{m})} \leq \sigma_{\text{yield}}$
 : tracing the mode shape
 : $Mt=6 \%$



†: The sensitivity was 2~3 % in the reference [15]

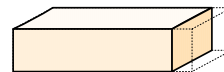
Selection of uncertain variables

Fabrication process

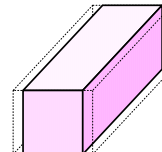


Error patterns

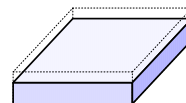
Length:



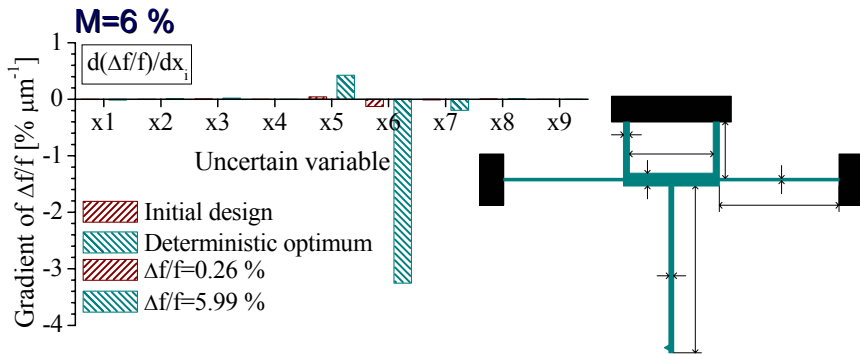
Width:



Thickness:



Sensitivity of $\Delta f/f$ w.r.t. uncertain variables



\Rightarrow Uncertain variables: $u_i = \{x_5, x_6, x_7, x_8, x_9\}$

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Robust optimization

Deterministic optimization

Maximize $\Delta f/f$ (%)
subject to $f_1 \geq 10000$ Hz
 $f_3 \geq 20000$ Hz
 $\sigma_{\max} \leq \sigma_{\text{yield}}$
 $f_{\Gamma 1i} - f_1 \leq 0.001$
 $\Delta f/f \cong M$



Robust optimization: M=6 %

Minimize GI
subject to $g_j + \Psi_j(g_j) \leq 0 \quad j=1,2,3$
 $f_{\Gamma 1i} - f_1 \leq 0.001$
 $\Delta f/f \cong M$

$$GI = \max_k \left| \frac{d(\Delta f/f)}{du_k} \right|$$

$u_i = \{x_5, x_6, x_7, x_8, x_9\}$

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Results

| Design variable | Lower bound | Initial design | M=6 % | | | Upper bound |
|-------------------------|-------------|----------------|-----------------------|-------------------------------|-------------------------------|-------------|
| | | | Deterministic optimum | Robust optimum 1 [†] | Robust optimum 2 [‡] | |
| x_1 μm | 1000 | 1000 | 1000.0 | 1000.0 | 1000.0 | 1500 |
| x_2 μm | 1000 | 2000 | 1991.4 | 2004.7 | 1997.9 | 3000 |
| x_3 μm | 200 | 300 | 300.9 | 260.2 | 248.1 | 500 |
| x_4 μm | 300 | 500 | 497.2 | 478.8 | 483.0 | 800 |
| x_5 μm | 3 | 20 | 42.2 | 79.9 | 79.9 | 80 |
| x_6 μm | 3 | 5 | 4.9 | 7.9 | 7.6 | 30 |
| x_7 μm | 10 | 50 | 31.6 | 47.8 | 46.6 | 100 |
| x_8 μm | 20 | 100 | 115.1 | 181.8 | 168.7 | 200 |
| x_9 μm | 15 | 20.5 | 24.9 | 25.0 | 25.0 | 25 |
| $\Delta f/f$ % | | 0.26 | 5.99 | 5.99 | 5.99 | |
| GI % μm^{-1} | | 0.12 | 3.25 | 1.81 | 1.84 | |
| f_1 Hz | | 10024 | 9999 | 15768 | 15439 | |
| f_1 Hz | | 10011 | 9695 | 15287 | 14968 | |
| f_2 Hz | | 10037 | 10295 | 16233 | 15894 | |

[†]Robust optimum 1 : No feasibility robustness

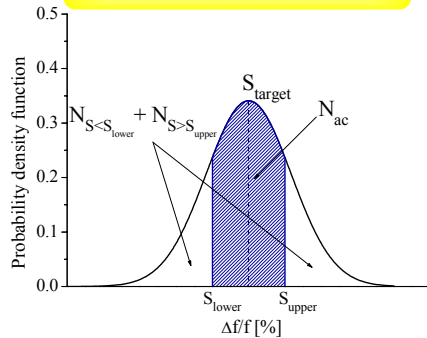
[‡]Robust optimum 2 : Feasibility robustness by Ψ_j with $\kappa_1=2.0$, $\kappa_2=2.0$, $\kappa_3=2.0$

Monte Carlo simulation

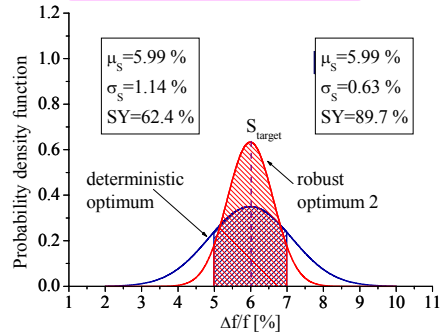
| M=6 % | | Deterministic optimum | Robust optimum 1 | Robust optimum 2 |
|-----------------------|---------------------------|---------------------------|------------------|------------------|
| | | Variation II [‡] | Variation II | Variation II |
| Mean \pm | $\Delta f/f$ % | 5.99 \pm 1.14 | 5.99 \pm 0.62 | 5.99 \pm 0.63 |
| | f_1 Hz | 10000 \pm 669 | 15768 \pm 660 | 15439 \pm 665 |
| Standard deviation | f_3 Hz | 20000 \pm 149 | 19980 \pm 138 | 20146 \pm 139 |
| | σ_{max} MPa | 8.7 \pm 0.06 | 16.4 \pm 0.06 | 16.3 \pm 0.06 |
| Violation probability | g_1 % | 50.0 | 0.0 | 0.0 |
| | g_2 % | 41.7 | 46.7 | 10.6 |
| | g_3 % | 0.0 | 0.0 | 0.0 |
| | g_4 % | 0.0 | 0.0 | 0.0 |
| Yield | SY % | 62.4 | 90.0 | 89.7 |

[‡]Variation II : $\Delta x_1=\Delta x_2=\Delta x_3=\Delta x_4=\pm 2.0$ μm , $\Delta x_5=\Delta x_6=\Delta x_7=\Delta x_8=\pm 1.0$ μm and $\Delta x_9=\pm 0.5$ μm

$$SY(\%) = \frac{N - (N_{g4} + N_S)}{N} \times 100(\%)$$



$$\begin{aligned} \Delta x_1 = \Delta x_2 = \Delta x_3 = \Delta x_4 = \pm 2.0 \mu\text{m} \\ \Delta x_5 = \Delta x_6 = \Delta x_7 = \Delta x_8 = \pm 1.0 \mu\text{m} \\ \Delta x_9 = \pm 0.5 \mu\text{m} \end{aligned}$$



†: Monte Carlo simulation using 1000 samples

Structural Reliability

■ Reliability

- Ability to fulfill the design purpose for an intended period
- Probability that a structure will not reach any specified limit state

■ Limit State

State beyond which a structure, or a part of it, can no longer fulfill the functions or satisfy the conditions for which it was designed

E.g.: Stress condition, Displacement condition, Frequency Buckling conditions, etc.

■ Failure Function / Limit State Function $G(\mathbf{X})$

The boundary of a safety domain D in the space of random variable \mathbf{X}

Optimal design formulation--probabilistic

$$\min W(\mathbf{b})$$

$$H_i(\mathbf{b}, \mathbf{z}, \mathbf{x}) = 0 \quad i = 1, \dots, s \quad (\text{State eqn})$$

$$\Pr \left[\bigcup_{j=1}^m \{G_j(\mathbf{b}, \mathbf{z}, \mathbf{x}) \leq 0\} \right] \leq p_0 \quad (\text{Sys failure mode})$$

$$\Pr[G_j(\mathbf{b}, \mathbf{z}, \mathbf{x}) \leq 0] \leq p_j, \quad j = m+1, \dots, m'$$

$$G_j(\mathbf{b}) \leq 0, \quad j = m'+1, \dots, m''$$

$$\text{Reliability:} \quad 1 - P_f$$

$$P_f = \Pr[G(\mathbf{X}) \leq 0] = \int_{G(\mathbf{X}) \leq 0} f(\mathbf{X}) d\mathbf{X}$$

Reliability analysis: Level 3 Methods

Monte Carlo Simulation

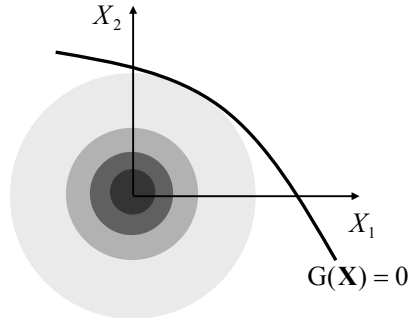
■ Concept

$$P_f = \Pr[G(\mathbf{X}) \leq 0] = \int_{G(\mathbf{X}) \leq 0} f(\mathbf{X}) d\mathbf{X}$$

$$P_f = \int I[G(\mathbf{X}) \leq 0] f(\mathbf{X}) d\mathbf{X}$$

$$P_f \approx \frac{1}{N} \sum_{i=1}^N I[G(\mathbf{X}_i) \leq 0]$$

$I[\bullet]$: Indicator function

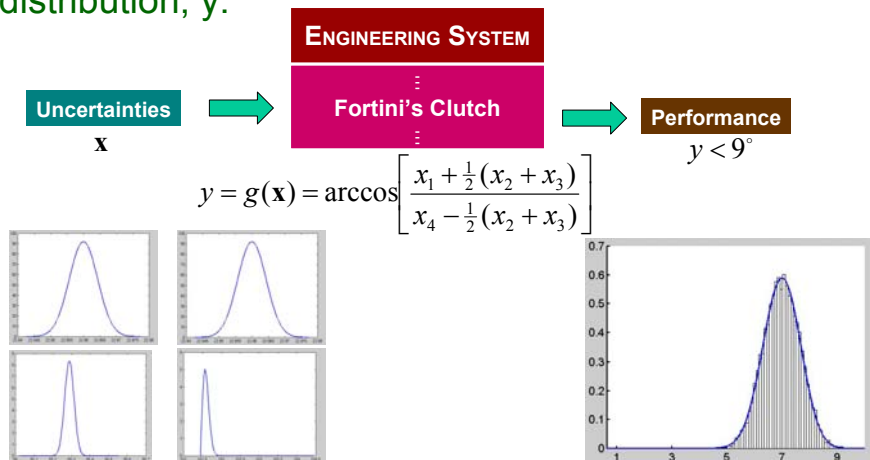


1. Generate random samples for \mathbf{X}_i
2. Compute $G(\mathbf{X}_i)$ and $I[G(\mathbf{X}_i) \leq 0]$
3. Calculate P_f

■ Too much calculation and accuracy problem

Moment method

■ To find probability moments and eventually the distribution, y .

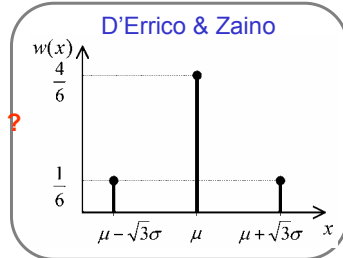
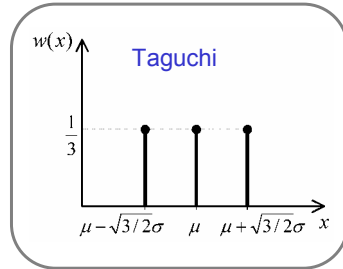
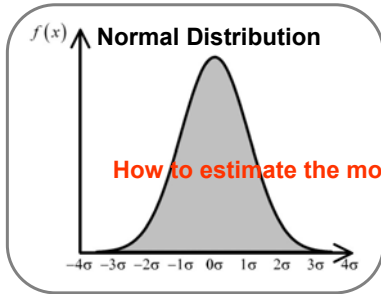


Design of Experiment

Three-Level Taguchi Method

$$E\{g^k\} = \int_{-\infty}^{+\infty} [g(x)]^k \phi\left(\frac{x-\mu}{\sigma}\right) dx$$

$$\cong \sum_{i=1}^m w_i [g(\mu + \alpha_i \sigma)]^k$$



Full Factorial DOE

3ⁿ Factorial Design : Normal Distribution

$$E\{g^k\} = \int_{-\infty}^{+\infty} \dots \int_{-\infty}^{+\infty} [g(x_1, \dots, x_n)]^k \prod_{i=1}^n \phi\left(\frac{x_i - \mu_i}{\sigma_i}\right) dx_1 \dots dx_n$$

(D'Errico & Zaino)

$$\cong \sum_{j_1=1}^m w_{j_1} \dots \sum_{j_n=1}^m w_{j_n} [g(\mu_1 + \alpha_{j_1} \sigma_1, \dots, \mu_n + \alpha_{j_n} \sigma_n)]^k$$

| Exp. | Level | | Weight |
|------|-------|-------|--------|
| k | j_1 | j_2 | $W(k)$ |
| 1 | | 1 | 1/36 |
| 2 | 1 | 2 | 4/36 |
| 3 | 1 | 3 | 1/36 |
| 4 | 2 | 1 | 4/36 |
| 5 | 2 | 2 | 16/36 |
| 6 | 2 | 3 | 4/36 |
| 7 | 3 | 1 | 1/36 |
| 8 | 3 | 2 | 4/36 |
| 9 | 3 | 3 | 1/36 |

$$y = g(x_1, x_2, \dots, x_n)$$

$$g(\mathbf{x}(k))$$

$$W(k) = w_{j_1} w_{j_2} \dots w_{j_n}$$

1. mean

$$\mu_g = \sum_{k=1}^{3^n} g(\mathbf{x}(k)) W(k)$$

3. skewness

$$\sqrt{\beta_{1g}} = \sum_{k=1}^{3^n} \frac{[g(\mathbf{x}(k)) - \mu_g]^3}{\sigma_g^3} W(k)$$

2. standard deviation

$$\sigma_g = \sqrt{\sum_{k=1}^{3^n} [g(\mathbf{x}(k)) - \mu_g]^2 W(k)}$$

4. kurtosis

$$\beta_{2g} = \sum_{k=1}^{3^n} \frac{[g(\mathbf{x}(k)) - \mu_g]^4}{\sigma_g^4} W(k)$$

DOE for non-normal distributions

3rd Factorial Design : Non-normal Distribution

$$M_k = \int_{-\infty}^{+\infty} (x - \mu)^k f(x) dx$$

$$\cong w_1 (l_1 - \mu)^k + w_2 (l_2 - \mu)^k + \dots + w_m (l_m - \mu)^k \quad (k = 0, 1, 2, 3, 4, \text{ and } 5)$$

$$w_1 + w_2 + w_3 = 1$$

$$w_1 l_1 + w_2 l_2 + w_3 l_3 = \mu$$

$$(l_1 - \mu)^2 w_1 + (l_2 - \mu)^2 w_2 + (l_3 - \mu)^2 w_3 = \sigma^2$$

$$\frac{(l_1 - \mu)^3 w_1 + (l_2 - \mu)^3 w_2 + (l_3 - \mu)^3 w_3}{\sigma^3} = \sqrt{\beta_1}$$

$$\frac{(l_1 - \mu)^4 w_1 + (l_2 - \mu)^4 w_2 + (l_3 - \mu)^4 w_3}{\sigma^4} = \beta_2$$

$$(l_1 - \mu)^5 w_1 + (l_2 - \mu)^5 w_2 + (l_3 - \mu)^5 w_3 = M_5$$

(Seo & Kwak 2002)

$$l_2 = \mu + \Delta$$

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Design of Experiments

Set $\Delta = 0$

$$\{l_1, l_2, l_3\} = \begin{bmatrix} \mu + \frac{\sqrt{\beta_1} \sigma}{2} - \frac{\sigma}{2} \sqrt{4\beta_2 - 3\beta_1} \\ \mu \\ \mu + \frac{\sqrt{\beta_1} \sigma}{2} + \frac{\sigma}{2} \sqrt{4\beta_2 - 3\beta_1} \end{bmatrix}^T, \{w_1, w_2, w_3\} = \begin{bmatrix} \frac{(4\beta_2 - 3\beta_1) + \sqrt{\beta_1} \sqrt{4\beta_2 - 3\beta_1}}{2(4\beta_2 - 3\beta_1)(\beta_2 - \beta_1)} \\ \frac{\beta_2 - \beta_1 - 1}{\beta_2 - \beta_1} \\ \frac{(4\beta_2 - 3\beta_1) - \sqrt{\beta_1} \sqrt{4\beta_2 - 3\beta_1}}{2(4\beta_2 - 3\beta_1)(\beta_2 - \beta_1)} \end{bmatrix}^T$$

Statistical moments of $g(x_1, x_2, \dots, x_n)$: Product Quadrature Rule

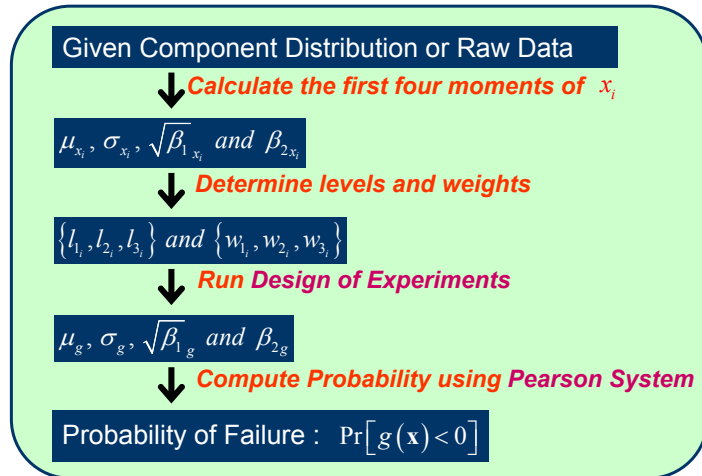
$$\mu_g = \sum_{i_1=1}^3 w_{i_1} \dots \sum_{i_n=1}^3 w_{i_n} g(l_{i_1}, \dots, l_{i_n}), \quad \sigma_g = \left[\sum_{i_1=1}^3 w_{i_1} \dots \sum_{i_n=1}^3 w_{i_n} (g(l_{i_1}, \dots, l_{i_n}) - \mu_g)^2 \right]^{1/2},$$

$$\sqrt{\beta_1}_g = \left[\sum_{i_1=1}^3 w_{i_1} \dots \sum_{i_n=1}^3 w_{i_n} (g(l_{i_1}, \dots, l_{i_n}) - \mu_g)^3 \right] / \sigma_g^3, \quad \beta_2_g = \left[\sum_{i_1=1}^3 w_{i_1} \dots \sum_{i_n=1}^3 w_{i_n} (g(l_{i_1}, \dots, l_{i_n}) - \mu_g)^4 \right] / \sigma_g^4.$$

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Full factorial DOE procedure (FFMM)

Reliability Analysis Using DOE (Seo & Kwak 2002)



Probability distribution system

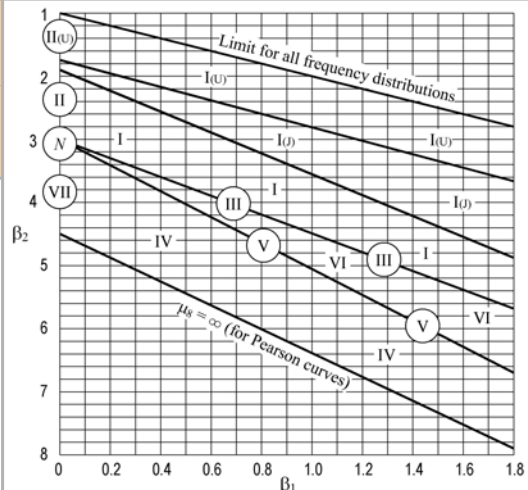
Pearson System – Probability Density Function

Pearson system

$$\frac{d}{dX}(\log f(x)) = \frac{X}{B_0 + B_1X + B_2X^2}$$

where $X = x - \mu$

- Type I** beta distribution
- Type II** symmetrical form of the function defined in Type I
- Type III** gamma distribution
- Type IV** no common statistical distributions are of the type
- Type V** inverse Gaussian distribution
- Type VI** cumulative Pareto distribution
- Type VII** t distribution



Response Surface-Moment Method (RSMM)

■ Motivation

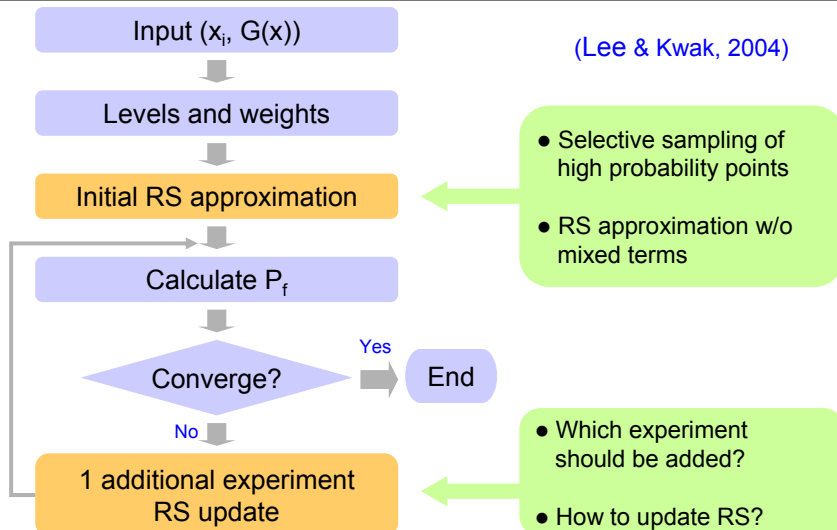
- Full factorial moment method (FFMM) is **too expensive** to use. # of uncertain parameters < 10

■ Strategy

- Strong points of FFMM or 3^n DOE must be preserved. → Utilize the levels and weights by Seo & Kwak.
- Retrieve as much information as possible from experimental data. → Utilize the same data for moment estimation and curve fitting.
- The number of experiments is increased adaptively to obtain the accuracy of FFMM. → Selective sampling and RS update utilized.

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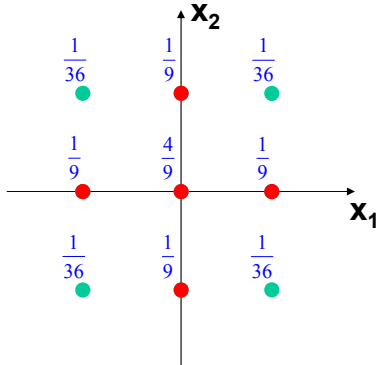
Expanding RS-Moment Method (RSMM)



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Initial approximation

Experiments with high probability concentration



$$w_i = w_{1i} \cdot w_{2i} \cdot \dots \cdot w_{ni} = \prod_{j=1}^n w_{ji}$$

w_{ji} : weight of j -th variable at i -th experiment ($j=1 \sim n, i=1 \sim 3^n$)

$$\tilde{G}(\mathbf{x}) = a + \sum_{i=1}^n b_i x_i + \sum_{i=1}^n c_i x_i^2$$

- Total **(1+2n)** REAL experiments
- $G(\mathbf{x})$ is approximated by $\tilde{G}(\mathbf{x})$ for the rest of experimental points

Least square approximation

$$y_i = a_0 + b_1 x_{i1} + \dots + b_n x_{in} + c_1 x_{i1}^2 + \dots + c_n x_{in}^2 + \varepsilon_i$$

$$= a_0 + \sum_{j=1}^n b_j x_{ij} + \sum_{j=1}^n c_j x_{ij}^2 + \varepsilon_i$$

$$\mathbf{y} = \mathbf{X}\boldsymbol{\beta} + \boldsymbol{\varepsilon}$$

$$\mathbf{y} = \begin{bmatrix} y_1 \\ y_2 \\ \vdots \\ y_k \end{bmatrix}, \quad \mathbf{X} = \begin{bmatrix} 1 & x_{11} & \dots & x_{1n} & x_{11}^2 & \dots & x_{1n}^2 \\ 1 & x_{21} & \dots & x_{2n} & x_{21}^2 & \dots & x_{2n}^2 \\ \vdots & \vdots & & \vdots & \vdots & & \vdots \\ 1 & x_{k1} & \dots & x_{kn} & x_{k1}^2 & \dots & x_{kn}^2 \end{bmatrix}$$

$$\boldsymbol{\beta} = \begin{bmatrix} a_0 \\ b_1 \\ \vdots \\ c_n \end{bmatrix}, \quad \boldsymbol{\varepsilon} = \begin{bmatrix} \varepsilon_1 \\ \varepsilon_2 \\ \vdots \\ \varepsilon_k \end{bmatrix}$$

$$L = \sum_{i=1}^k \varepsilon_i^2 = \boldsymbol{\varepsilon}^T \boldsymbol{\varepsilon} = (\mathbf{y} - \mathbf{X}\boldsymbol{\beta})^T (\mathbf{y} - \mathbf{X}\boldsymbol{\beta})$$

$$L = \mathbf{y}^T \mathbf{y} - \boldsymbol{\beta}^T \mathbf{X}^T \mathbf{y} - \mathbf{y}^T \mathbf{X}\boldsymbol{\beta} + \boldsymbol{\beta}^T \mathbf{X}^T \mathbf{X}\boldsymbol{\beta}$$

$$= \mathbf{y}^T \mathbf{y} - 2\boldsymbol{\beta}^T \mathbf{X}^T \mathbf{y} + \boldsymbol{\beta}^T \mathbf{X}^T \mathbf{X}\boldsymbol{\beta}$$

$$\left. \frac{\partial L}{\partial \boldsymbol{\beta}} \right|_{\mathbf{b}} = -2\mathbf{X}^T \mathbf{y} + 2\mathbf{X}^T \mathbf{X}\mathbf{b} = 0$$

$$\mathbf{b} = (\mathbf{X}^T \mathbf{X})^{-1} \mathbf{X}^T \mathbf{y}$$

b : Least square estimator of $\boldsymbol{\beta}$

Selection of new experimental point

- Find a candidate point which is likely to make the biggest change in Pf.

$$\Delta P_f = \frac{dP_f}{d\tilde{g}_i} (\tilde{g}_i - g_i)$$

- g_i : value of $G(\mathbf{x})$ at i-th experimental point ($i=1 \sim 3^n - 2n - 1$)
- \tilde{g}_i : value of $\tilde{G}(\mathbf{x})$ at i-th experimental point ($i=1 \sim 3^n - 2n - 1$)

- $\left| \frac{dP_f}{d\tilde{g}_i} \right|$ is selected as a measure of the relative importance of experimental points, to be called **influence index**

Influence Index

- Calculation of Influence Index

$$\begin{aligned} P_f &= P_f(\mu, \sigma, \sqrt{\beta_1}, \beta_2) \\ \frac{dP_f}{dg_i} &= \frac{\partial P_f}{\partial \mu} \cdot \frac{\partial \mu}{\partial g_i} + \frac{\partial P_f}{\partial \sigma} \cdot \frac{\partial \sigma}{\partial g_i} + \frac{\partial P_f}{\partial \sqrt{\beta_1}} \cdot \frac{\partial \sqrt{\beta_1}}{\partial g_i} + \frac{\partial P_f}{\partial \beta_2} \cdot \frac{\partial \beta_2}{\partial g_i} \\ &\approx \frac{\Delta P_f}{\Delta \mu} \cdot \frac{\partial \mu}{\partial g_i} + \frac{\Delta P_f}{\Delta \sigma} \cdot \frac{\partial \sigma}{\partial g_i} + \frac{\Delta P_f}{\Delta \sqrt{\beta_1}} \cdot \frac{\partial \sqrt{\beta_1}}{\partial g_i} + \frac{\Delta P_f}{\Delta \beta_2} \cdot \frac{\partial \beta_2}{\partial g_i} \end{aligned}$$

- Differentiation using chain rule.
- $\frac{\Delta P_f}{\Delta \mu}, \frac{\Delta P_f}{\Delta \sigma}, \frac{\Delta P_f}{\Delta \sqrt{\beta_1}}, \frac{\Delta P_f}{\Delta \beta_2}$ can be calculated by

by the Pearson system and finite difference method.

Influence Index

Cont'd

$$\mu = \sum_{i=1}^n w_i g_i, \quad \frac{\partial \mu}{\partial g_i} = w_i$$

$$\sigma = \sqrt{\sum_{i=1}^n w_i (g_i - \mu)^2}, \quad \frac{\partial \sigma}{\partial g_i} = \frac{w_i}{\sigma} \left((g_i - \mu) - \sum_{j=1}^n w_j^2 (g_j - \mu) \right)$$

$$\sqrt{\beta_1} = \frac{\sum_{i=1}^n w_i (g_i - \mu)^3}{\sigma^3}, \quad \frac{\partial \sqrt{\beta_1}}{\partial g_i} = 3w_i \cdot \frac{(g_i - \mu)^2 - \sum_{j=1}^n w_j^2 (g_j - \mu)^2}{\sigma^3} - 3 \cdot \frac{\frac{\partial \sigma}{\partial g_i} \sum_{j=1}^n w_j (g_j - \mu)^3}{\sigma^4}$$

$$\beta_2 = \frac{\sum_{i=1}^n w_i (g_i - \mu)^4}{\sigma^4}, \quad \frac{\partial \beta_2}{\partial g_i} = 4w_i \cdot \frac{(g_i - \mu)^3 - \sum_{j=1}^n w_j^2 (g_j - \mu)^3}{\sigma^4} - 4 \cdot \frac{\frac{\partial \sigma}{\partial g_i} \sum_{j=1}^n w_j (g_j - \mu)^4}{\sigma^5}$$

Update of response surface

- Experiment is added one by one.
- Mixed term $x_i x_j$ can be added to RS formulation

$$\tilde{g}(\mathbf{x}) = a + \sum_{i=1}^n b_i x_i + \sum_{i=1}^n c_i x_i^2 + \sum_{k=1}^{nmix} d_k x_{i(k)} x_{j(k)}$$

Which term should be added?

- Consider the level combination of the newly added experiments,

$x_1(0):x_2(1):x_3(0):x_4(-1):x_5(1)$

Candidates : $x_2 \cdot x_4, x_2 \cdot x_5, x_4 \cdot x_5$

Update of response surface

■ Cont'd

- Select a mixed term $x_i \cdot x_j$ that has greatest value of

$$cs_{ij} = |b_i| + |c_i| + |b_j| + |c_j|$$

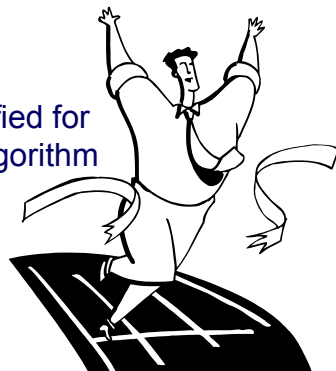
- If the selected term is already included in the formulation, then select $x_i \cdot x_j$ with the next biggest cs_{ij}
- More than one term can be added.

Convergence check

■ Convergence criteria

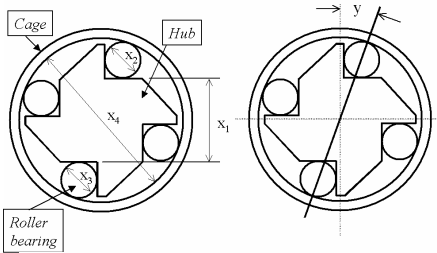
$$\left| \frac{P_f - P_{f0}}{P_{f0}} \right| < \varepsilon$$

- If the convergence criterion is satisfied for 3 consecutive experiments, then algorithm terminates.



Ex. 1 : Fortini's Clutch

Fortini's Clutch Greenwood and chase, 1990



System response function

$$y = \arccos \left[\frac{x_1 + \frac{1}{2}(x_2 + x_3)}{x_4 - \frac{1}{2}(x_2 + x_3)} \right]$$

System requirement

$$5^\circ \leq y \leq 9^\circ$$

| Component | $f(\cdot)$ | | Mean | STD | Parameter for nonnormal distribution |
|-----------|------------|----------|----------|----------|--------------------------------------|
| x_1 | normal | beta | 55.29mm | 0.0793mm | $\gamma_1 = \eta_1 = 5.0$ |
| x_2 | normal | normal | 22.86mm | 0.0043mm | $(55.0269 \leq x_1 \leq 55.5531)$ |
| x_3 | normal | normal | 22.86mm | 0.0043mm | $\hat{\sigma}_4 = 0.1211$ |
| x_4 | normal | Rayleigh | 101.60mm | 0.0793mm | $(x_4 \geq 101.45)$ |

KAIST

Ex. 1 : Fortini's Clutch

First approximation ($y \leq 6^\circ$)

Number of experiments at first approximation : 9

Number of terms in RS approximation : 9

RS coefficient at first approximation

| | |
|-------------|----------------|
| 0.12506456 | a |
| -0.01320876 | b ₁ |
| -0.00077123 | b ₂ |
| -0.00077123 | b ₃ |
| 0.01383499 | b ₄ |
| -0.00071070 | c ₁ |
| -0.00000245 | c ₂ |
| -0.00000245 | c ₃ |
| -0.00080407 | c ₄ |

mean : 0.12193950
 std : 0.01159093
 skewness : 0.09206418
 kurtosis : 2.90359915
 pr_failure : 0.06664917

| | Proposed Method | | FDM ($\Delta=0.001$) | | Error |
|-----|--|----------|--|----------|-------|
| | $\left \frac{dP_f}{d\hat{g}_i} \right $ | Exp. No. | $\left \frac{\Delta P_f}{\Delta \hat{g}_i} \right $ | Exp. No. | |
| 1 | 1.476153 | 67 | 1.369570 | 67 | 7.5% |
| 2 | 0.551716 | 77 | 0.561110 | 77 | 5.7% |
| 3 | 0.551716 | 71 | 0.561110 | 71 | 5.7% |
| 4 | 0.483171 | 59 | 0.495354 | 59 | 6.9% |
| 5 | 0.483171 | 65 | 0.495354 | 65 | 6.9% |
| ... | | | | | |

KAIST

Ex. 1 : Fortini's Clutch

Second approximation

experiment 67 is executed additionally.
Number of experiments : 10
Term $x_1 \times x_4$ is included in exp. coordinate
Term $x_1 \times x_4$ is added
Number of terms in RS approximation : 10
RS coefficient at first approximation

| | |
|-------------|----------------------|
| 0.12506456 | a |
| -0.01280947 | b₁ |
| -0.00077123 | b₂ |
| -0.00077123 | b₃ |
| 0.01383499 | b₄ |
| -0.00071070 | c₁ |
| -0.00000245 | c₂ |
| -0.00000245 | c₃ |
| -0.00080407 | c₄ |
| 0.00217198 | d₃ |

mean : 0.12193950
std : 0.01161810
skewness : -0.10661204
kurtosis : 2.84110933
pr_failure : 0.07332022

| Exp. | $\frac{dP_f}{d\tilde{g}_i}$ |
|------|-----------------------------|
| 71 | 0.559847 |
| 77 | 0.559847 |
| 59 | 0.502577 |
| 65 | 0.502577 |
| 49 | 0.484110 |
| ... | |

Ex. 1 : Fortini's Clutch

Fourth approximation

experiment 59 is executed additionally.
Number of experiments : 13
Term $x_1 \times x_2$ is included in exp. coordinate
No term is added
Number of terms in RS approximation : 12
RS coefficient at first approximation

| | |
|-------------|----------------------|
| 0.12506493 | a |
| -0.01280981 | b₁ |
| -0.00077123 | b₂ |
| -0.00077123 | b₃ |
| 0.01383499 | b₄ |
| -0.00071123 | c₁ |
| -0.00000298 | c₂ |
| -0.00000281 | c₃ |
| -0.00080444 | c₄ |
| -0.00009912 | d₁ |
| -0.00009947 | d₂ |
| 0.00217111 | d₃ |

mean : 0.12193919
std : 0.01161827
skewness : -0.10761175
kurtosis : 2.84166700
pr_failure : 0.07335008

Ex. 1 : Fortini's Clutch

Results

| | HL-RF * | 3 ⁿ moment | RSM moment | MCS (1,000k) |
|-----------------------|-----------------|-----------------------|---------------|--------------|
| μ_G | • | 0.121930 | 0.121939 | 0.121926 |
| σ_G | • | 0.011687 | 0.011618 | 0.011694 |
| $\sqrt{\beta_{1G}}$ | • | -0.057661 | -0.107611 | -0.051593 |
| β_{2G} | • | 2.921503 | 2.841667 | 2.880998 |
| $\Pr(y \leq 5^\circ)$ | Diverge | 0.001580 | 0.001459 (13) | 0.001288 |
| $\Pr(y \leq 6^\circ)$ | 0.087656 (8,40) | 0.072562 | 0.073350 (13) | 0.073922 |
| $\Pr(y \leq 7^\circ)$ | 0.520349 (5,25) | 0.504294 | 0.504847 (13) | 0.503160 |
| $\Pr(y \leq 8^\circ)$ | 0.936942 (3,15) | 0.936245 | 0.935951 (12) | 0.936726 |
| $\Pr(y \leq 9^\circ)$ | 0.999448 (3,15) | 0.999250 | 0.999288 (12) | 0.999190 |
| No. of fn call | (iteration, #) | 81 | (#) | 1,000,000 |

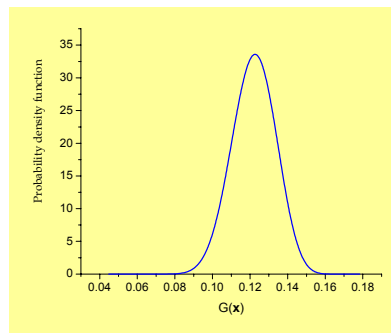
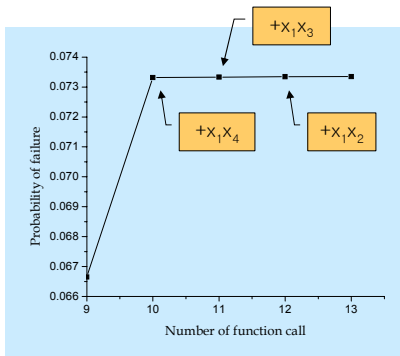
KAIST * : 2 iteration schemes and 2 transformation schemes are tried

Ex. 1 : Fortini's Clutch

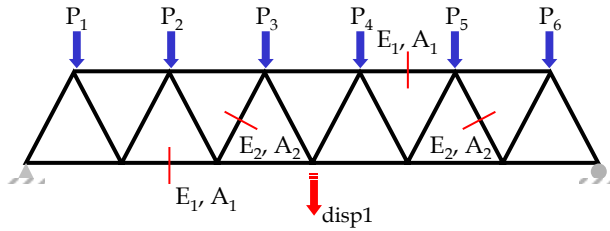
Results

$$\tilde{g}(\mathbf{x}(\xi)) = 0.1251 - 0.0128\xi_1 - 0.0008\xi_2 - 0.0008\xi_3 - 0.0138\xi_4 - 0.0008\xi_1^2 - 0.0008\xi_4^2 - 0.0001\xi_1\xi_2 - 0.0001\xi_1\xi_3 + 0.0022\xi_1\xi_4$$

$$\xi_i = \frac{x_i - (l_{i3} + l_{i1})/2}{(l_{i3} - l_{i1})/2}$$



Ex. 2 : Truss Structure



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$$g(\mathbf{x}) = 11 - disp1 \leq 0$$

Ex. 2 : Truss Structure

$$\begin{aligned}
 g(\mathbf{x}(\xi)) = & 2.8070 + 1.2598\xi_1 + 0.2147\xi_2 + 1.2559\xi_3 + 0.2133\xi_4 - 0.1510\xi_5 \\
 & - 0.4238\xi_6 - 0.6100\xi_7 - 0.6100\xi_8 - 0.4238\xi_9 - 0.1510\xi_{10} \\
 & - 0.1978\xi_1^2 - 0.0362\xi_2^2 - 0.2016\xi_3^2 - 0.0346\xi_4^2 + 0.0023\xi_5^2 \\
 & + 0.0008\xi_6^2 + 0.0036\xi_7^2 + 0.0036\xi_8^2 + 0.0008\xi_9^2 + 0.0023\xi_{10}^2 \\
 & - 0.0042\xi_1\xi_2 - 0.3022\xi_1\xi_3 - 0.0110\xi_1\xi_4 + 0.0381\xi_1\xi_5 + 0.0871\xi_1\xi_6 \\
 & + 0.1232\xi_1\xi_7 + 0.1232\xi_1\xi_8 + 0.0871\xi_1\xi_9 + 0.0346\xi_1\xi_{10} + 0.0041\xi_2\xi_3 \\
 & + 0.0110\xi_3\xi_4 + 0.0261\xi_3\xi_5 + 0.0831\xi_3\xi_6 + 0.1172\xi_3\xi_7 + 0.1172\xi_3\xi_8 \\
 & + 0.0832\xi_3\xi_9 + 0.0296\xi_3\xi_{10}
 \end{aligned}$$

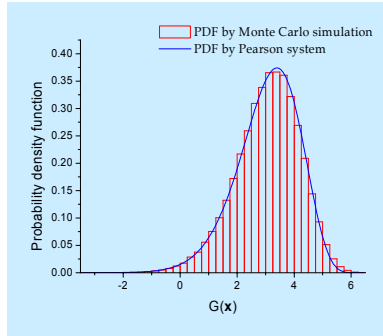
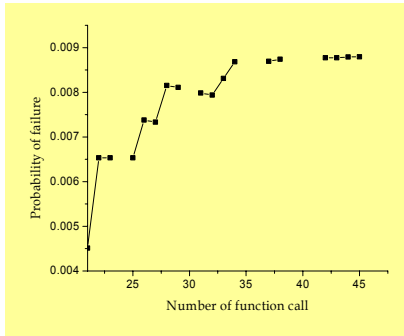
$$\xi_i = \frac{x_i - (l_{i3} + l_{i1})/2}{(l_{i3} - l_{i1})/2}$$

| | | | | |
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Ex. 2 : Truss Structure

Results

- 23 additional experiments (17 terms are added)
- Pearson type I (Beta distribution)



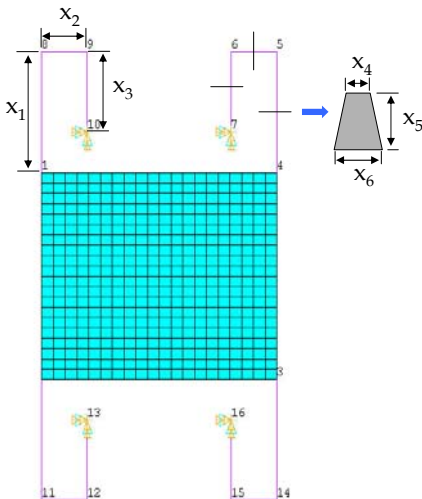
Ex. 3 : Micro-Gyroscope

Tanaka, et al, 1995

$$g(\mathbf{x}) = f_2 - f_1 \text{ (Hz)}$$

f_1 : First natural frequency

f_2 : Second natural frequency



Ex. 3 : Micro-Gyroscope



$$\begin{aligned} \tilde{g}(\mathbf{x}(\xi)) = & 62.7989 \\ & -2.0597\xi_1 + 5.7858\xi_2 - 1.3070\xi_3 + 45.4750\xi_4 - 64.1778\xi_5 + 66.8559\xi_6 \\ & + 0.0048\xi_1^2 - 0.0091\xi_2^2 - 0.0009\xi_3^2 + 4.5491\xi_4^2 + 17.7791\xi_5^2 + 32.3739\xi_6^2 \\ & - 0.0929\xi_1\xi_4 + 0.0518\xi_2\xi_4 - 0.1056\xi_3\xi_4 - 78.5515\xi_4\xi_5 + 0.0286\xi_4\xi_6 - 36.5115\xi_5\xi_6 \end{aligned}$$

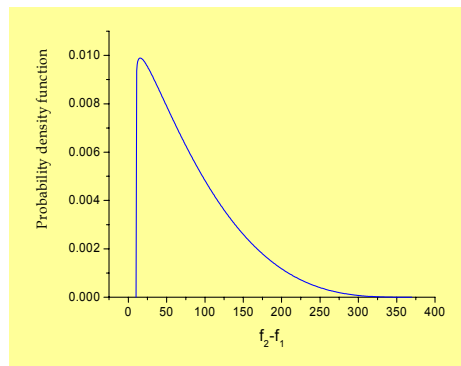
* : Moment results are for case $g(\mathbf{x}) > 100$

Ex. 3 : Micro-Gyroscope



Results

- 3~7 additional experiments (6 terms are added)
- Pearson type I (Beta distribution)



■ RS-Moment method (RSMM)

- Highly efficient and good accuracy
- Additional information available from the RS model
- The accuracy cannot exceed that of 3^n moment method (FFMM)

Reliability analysis: Level 2 Methods

AFOSM

Transformation \mathbf{T}

$$\mathbf{X} = \mathbf{T}\mathbf{u}$$

\mathbf{X} \rightarrow \mathbf{u}

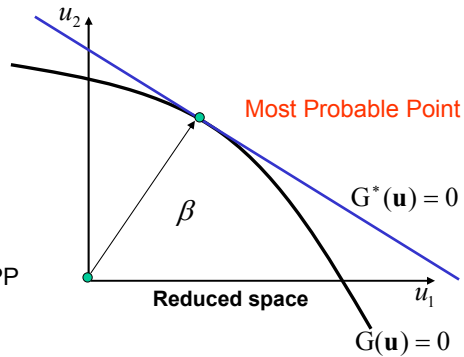
- Normal
- Independent
- Standard normal

Reliability index (RI) β

Minimum distance from origin to MPP

$$\begin{aligned} \min \quad & |\mathbf{u}| = \beta \\ \text{s.t.} \quad & G(\mathbf{u}) \leq 0 \end{aligned}$$

First-order Taylor expansion of $G(\mathbf{u})$ at MPP



$$P_f = \Pr(G(\mathbf{x}) \leq 0) \cong \Phi(-\beta)$$

RBDO Formulations with AFOSM

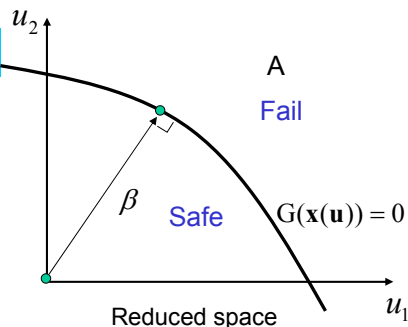
$$\Pr[G(\mathbf{b}, \mathbf{z}, \mathbf{x}) \leq 0] \leq p$$

1. Reliability index approach

$$1 - \Phi(\beta) \leq p$$

where $\beta = \min_{\mathbf{u} \in A} (\mathbf{u}^T \mathbf{u})^{1/2}$

$$A = \{\mathbf{u} : G(\mathbf{u}) \leq 0\}$$



Note: 1) A is dependent on \mathbf{b} , \mathbf{z} and \mathbf{x}

2) For large β , difficult to obtain good results

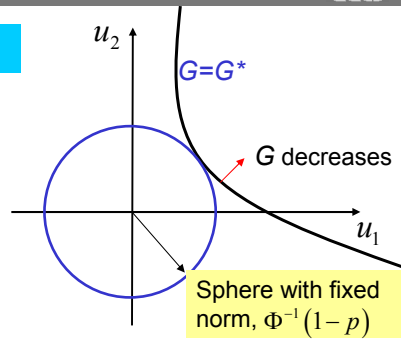
RBDO Formulations with AFOSM

2. Fixed norm approach (FNA)

$$G^* \geq 0$$

$$G^* = \min_{\mathbf{u} \in B} G(\mathbf{x}(\mathbf{u}))$$

$$\text{where } B = \left\{ \mathbf{u} \mid \left(\mathbf{u}^T \mathbf{u} \right)^{\frac{1}{2}} \leq \Phi^{-1}(1-p) \right\}$$



Note:

- 1) B is a sphere with a fixed norm in the reduced random variable space and independent of b and z. Even for large β , this works well
- 2) This transformed formulation, FNA, first developed by [Lee & Kwak, 1987-88]
- 3) Much later, [Tu & Choi, 1999] presented the same formulation by the name PMA (Performance Measure Approach). They did not cite our original work though.

KAIST

Sensitivity of probability

■ Sensitivity Analysis [Lee & Kwak, 1987]

$$\frac{d\hat{G}_j}{db} = ?$$

$$\hat{G}_j(b) = \min_{\mathbf{u}, \mathbf{z}} \begin{cases} G_j(\mathbf{b}, \mathbf{z}, \mathbf{u}) \geq 0 \\ \mathbf{H}(\mathbf{b}, \mathbf{z}, \mathbf{u}) = 0 \\ Q_j(\mathbf{b}, \mathbf{u}) \leq 0 \end{cases}$$

$$\min W(\mathbf{b})$$

$$H_i(\mathbf{b}, \mathbf{z}, \mathbf{x}) = 0 \quad i = 1, \dots, s$$

$$\Pr \left[\bigcup_{j=1}^m \{G_j(\mathbf{b}, \mathbf{z}, \mathbf{x}) \leq 0\} \right] \leq p_0$$

$$\Pr [G_j(\mathbf{b}, \mathbf{z}, \mathbf{x}) \leq 0] \leq p_j, \quad j = m+1, \dots, m'$$

$$G_j(\mathbf{b}) \leq 0, \quad j = m'+1, \dots, m''$$

$$\delta G_j = \left[\frac{\partial G_j}{\partial \mathbf{b}} + \lambda^T \frac{\partial \mathbf{H}}{\partial \mathbf{b}} + \mu \frac{\partial Q_j}{\partial \mathbf{b}} \right] \delta \mathbf{b}$$

Parametric optimal design (POD)

[Kwak & Haug, 1977]

KAIST

OD procedure using sensitivity

- Sensitivity analysis
 - Sensitivity of probability by POD
 - FDM sensitivity analysis using DOE
 - Original FDM → too expensive to use
- Any first order gradient method can be used.
- Example application area
 - Tolerance analysis and synthesis

Application: Tolerance Design

■ Tolerance Analysis

(Seo & Kwak 2002)

$$y_i = g_i(x_1, x_2, \dots, x_n) \quad (i = 1, 2, \dots, m, y_i = \bar{y}_i + u_i, x_j = \bar{x}_j + t_j)$$

$$\Delta y_i = \sum_{j=1}^n \frac{\partial g_i}{\partial x_j} \Delta x_j + \frac{1}{2} \sum_{j=1}^n \sum_{k=1}^n \frac{\partial^2 g_i}{\partial x_j \partial x_k} \Delta x_j \Delta x_k + \dots \approx \frac{\partial g_i}{\partial x_1} \Delta x_1 + \frac{\partial g_i}{\partial x_2} \Delta x_2 + \dots + \frac{\partial g_i}{\partial x_n} \Delta x_n$$

- Worst case method
- RSS technique
- FORM / SORM
- Monte Carlo simulation
- **DOE**

Tolerance Synthesis based on RBDO Concept

- Tolerance is a function of probability distribution parameters of dimensions.
For example, for 3σ quality, $\sigma = t/3$.
- System characteristics, $g(x)$, is a function of the random variables (dimensions), x , thus a function of tolerance, t .
- Functional requirement or quality may be described by inequality, $g(x) \geq 0$. This needs to be satisfied with some certainty.
- A tolerance allocation problem is then a problem of balancing between the cost and quality. This results in the same formulation as an RBDO.

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Tolerance Synthesis Problem Formulation

$$\begin{aligned} & \text{Minimize } \sum_i C_i(t_j) \\ & \text{subject to } \Pr_{safe} \geq \Pr_{Prescribed} \end{aligned}$$

or

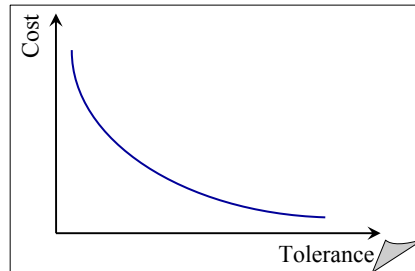
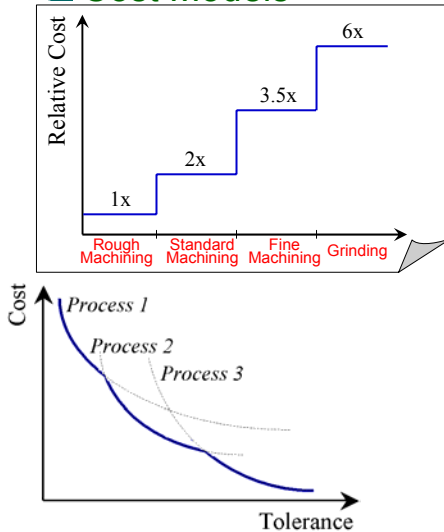
$$\begin{aligned} & \text{Maximize } \Pr_{safe} \\ & \text{subject to } \sum_i C_i(t_j) \leq C_{Prescribed} \end{aligned}$$

$$\text{where } \Pr_{safe} = \Pr(g(\mathbf{x}) \geq 0)$$

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Tolerance Optimization

Cost Models



Examples of Cost functions

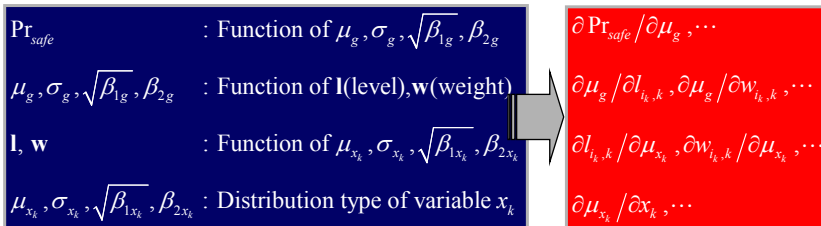
$$A + \frac{B}{t^r}, \quad A + \frac{B}{e^{st}}$$

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Design Sensitivity Analysis using DOE

Probabilistic constraint : $\Pr_{safe} = \Pr[g(\mathbf{x}) \geq 0] \geq Y_{spec}$

Sensitivity : $d \Pr_{safe} / d\mathbf{x}$



Derivative of performance function value : use previously obtained DOE data and chain rule

$$\frac{\partial \mu_g}{\partial l_{i,k}}, \frac{\partial \sigma_g}{\partial l_{i,k}}, \frac{\partial \sqrt{\beta_{1g}}}{\partial l_{i,k}}, \frac{\partial \beta_{2g}}{\partial l_{i,k}} \Rightarrow \frac{\partial g(\mathbf{l})}{\partial l_{1,k}}, \frac{\partial g(\mathbf{l})}{\partial l_{2,k}}, \frac{\partial g(\mathbf{l})}{\partial l_{3,k}}$$

KAIST

Example

Verification with the Fortini Clutch example

Constraint

$$G(\mathbf{t}) = \Pr_{spec} - \Pr[5^\circ \leq y(\mathbf{x}) \leq 9^\circ] \leq 0, \quad \text{where } \mathbf{x} = \boldsymbol{\mu} + \mathbf{t}$$

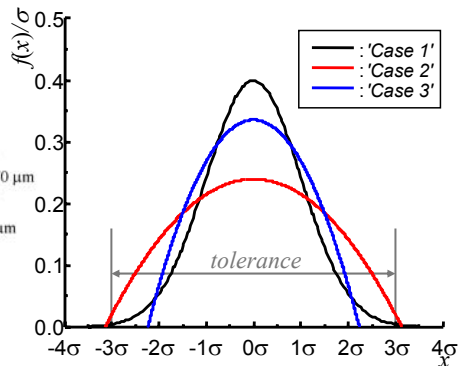
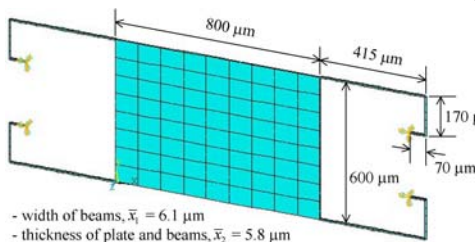
Comparison of the sensitivity results with FDM

| i | Sensitivity, $dG(\mathbf{t})/dt_i$ | |
|-----|------------------------------------|----------|
| | The proposed method | FDM* |
| 1 | 0.026416 | 0.026871 |
| 2 | 0.002059 | 0.002059 |
| 3 | 0.002059 | 0.002059 |
| 4 | 0.029027 | 0.029490 |

* In FDM, $\Delta t = 1 \times 10^{-5} \mathbf{t}$

Example

Micro-Gyroscope



$$\text{Minimize} \left(\frac{2 \times 10^{-2}}{t_1^{1.3}} + 200 \right) + \left(\frac{3 \times 10^{-2}}{t_2^{1.1}} + 200 \right)$$

subject to

$$\Pr[0 \leq f_2 - f_1 \leq 200] \geq 0.95$$

- Case 1 : normal distribution : s.t.d. = σ
- Case 2 : beta distribution : $\text{DPMO}_2 = \text{DPMO}_1$
- Case 3 : beta distribution : s.t.d. = σ

Examples

Sensitivity results

| Tolerance type | The proposed method | | FDM | | |
|----------------|---------------------|--------------|------------|--------------|--------------|
| | $dG(t)/dt_1$ | $dG(t)/dt_2$ | Δt | $dG(t)/dt_1$ | $dG(t)/dt_2$ |
| Case 1 | 86.207442 | 389.29906 | 10^{-3} | 86.313433 | 389.49592 |
| | | | 10^{-4} | 86.225993 | 388.94631 |
| | | | 10^{-5} | 84.941866 | 383.90791 |
| Case 2 | 132.30349 | 721.93610 | 10^{-3} | 132.48322 | 721.94789 |
| | | | 10^{-4} | 132.41351 | 721.79235 |
| | | | 10^{-5} | 132.80005 | 717.79549 |
| Case 3 | 118.13797 | 467.51404 | 10^{-3} | 1.1823083 | 4.6788787 |
| | | | 10^{-4} | 1.1830852 | 4.6745320 |
| | | | 10^{-5} | 1.1883938 | 4.6401483 |

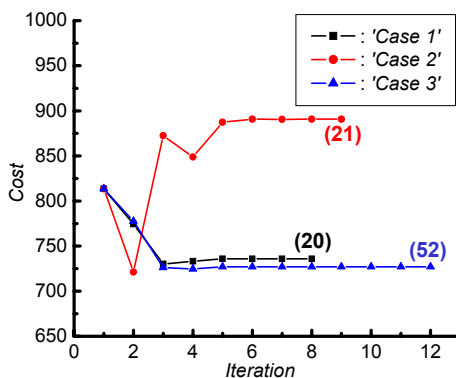
Optimization results

| Variable | The proposed method | | | FDM | | |
|------------|---------------------|---------------------|---------------------|---------------------|---------------------|---------------------|
| | Case 1 | Case 2 | Case 3 | Case 1 | Case 2 | Case 3 |
| t_1 | 0.944 μm | 0.698 μm | 0.969 μm | 0.946 μm | 0.698 μm | 0.978 μm |
| t_2 | 0.399 μm | 0.286 μm | 0.406 μm | 0.398 μm | 0.286 μm | 0.401 μm |
| $\sum C_i$ | 735.987 | 890.665 | 726.984 | 735.805 | 890.666 | 727.047 |

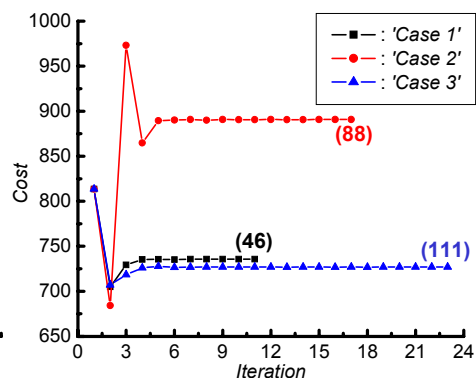
Example

Optimization history

• by the proposed method



• by FDM

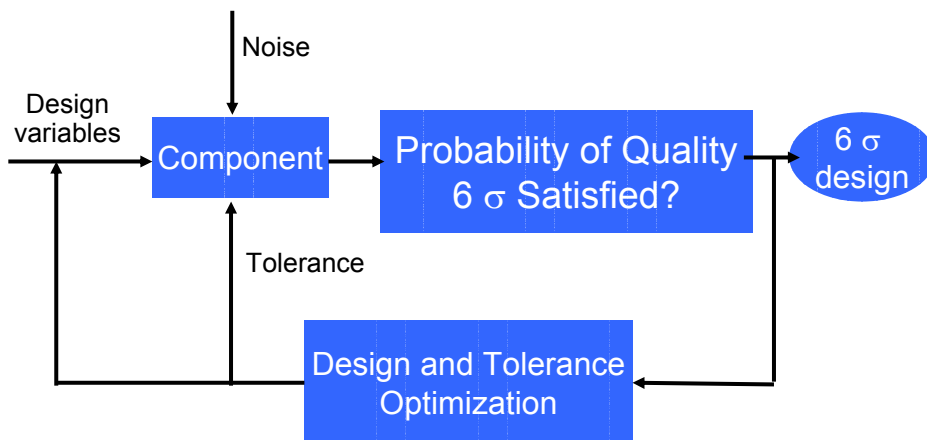


Summary

- Moment based DOE reliability analysis using 3-point probability concentration and Pearson system is developed for treating general distributions.
- Formal optimal design procedure for RBDO is developed with very good accuracy and applied to tolerance analysis and synthesis using previously obtained DOE data.
- Expanding response surface moment method (RSMM) is developed to drastically reduce the amount of computation even for a large number of random variables.
- Design for 6-sigma is possible with the methods developed.

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Design Optimization for 6 Sigma



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